

<b>Notice of References Cited</b>		Application/Control No.	Applicant(s)/Patent Under Reexamination CHEN, SHAO-CHUN	
		Examiner Diego Herrera	Art Unit 2617	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2005/0102615	05-2005	Roman et al.	715/513
*	B	US-2005/0096025	05-2005	Qumei et al.	455/418
*	C	US-2005/0071385	03-2005	Rao, Bindu Rama	707/200
*	D	US-2005/0005268	01-2005	Zilavy et al.	717/170
*	E	US-2004/0243993	12-2004	Okonnen et al.	717/168
*	F	US-2004/0243992	12-2004	Gustafson et al.	717/168
*	G	US-5,974,250	10-1999	Angelo et al.	713/100
*	H	US-2001/0029178	10-2001	Criss et al.	455/419
*	I	US-2006/0174242	08-2006	Zhu et al.	717/172
*	J	US-2005/0114504	05-2005	Marolia et al.	709/224
*	K	US-2005/0039178	02-2005	Marolia et al.	717/168
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.